

Notice of References Cited	Application/Control No. 10/719,192	Applicant(s)/Patent Under Reexamination BAEK ET AL.	
	Examiner Julia P. Tu	Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,732,113	03-1998	Schmidl et al.	375/355
*	B	US-2004/0146117	07-2004	Subramaniam et al.	375/260
*	C	US-2003/0076904	04-2003	Magee, David Patrick	375/340
*	D	US-6,195,534	02-2001	Sakoda et al.	455/45
*	E	US-7,161,896	01-2007	Hart et al.	370/206
*	F	US-2003/0050945	03-2003	Chen et al.	708/404
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
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	Q					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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